

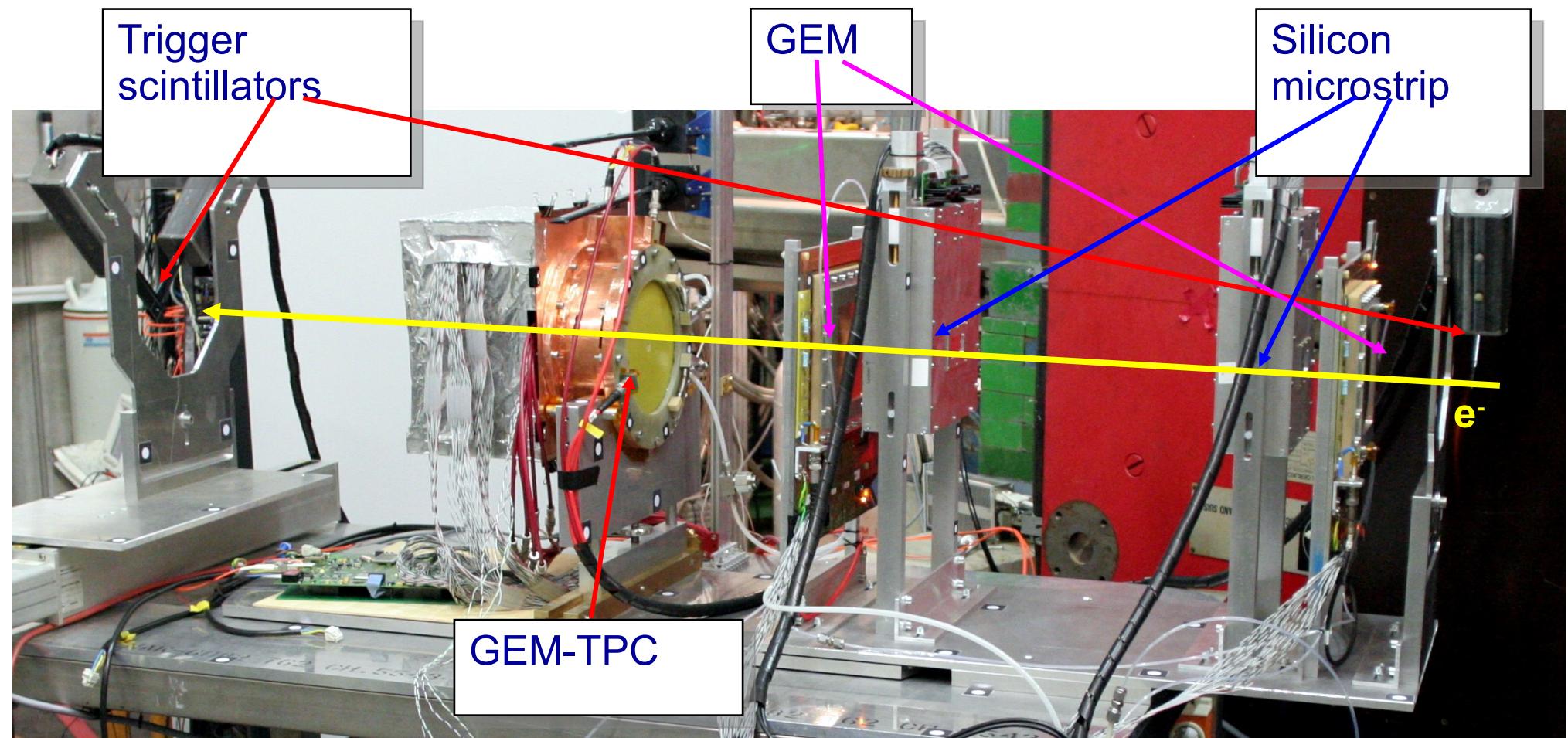
Test of the TPC at ELSA with sparse readout

Maxence Vandenbroucke, TUM E18,
for the GEM-TPC collaboration

XXX.PANDA meeting, Jülich, 08-09-2009

- GEM-TPC test bench
- Geometry and photometry
- Results of the tracking telescope
- GEM-TPC front end electronics
- First results of the TPC with a full sparse readout
- Conclusions and outlook

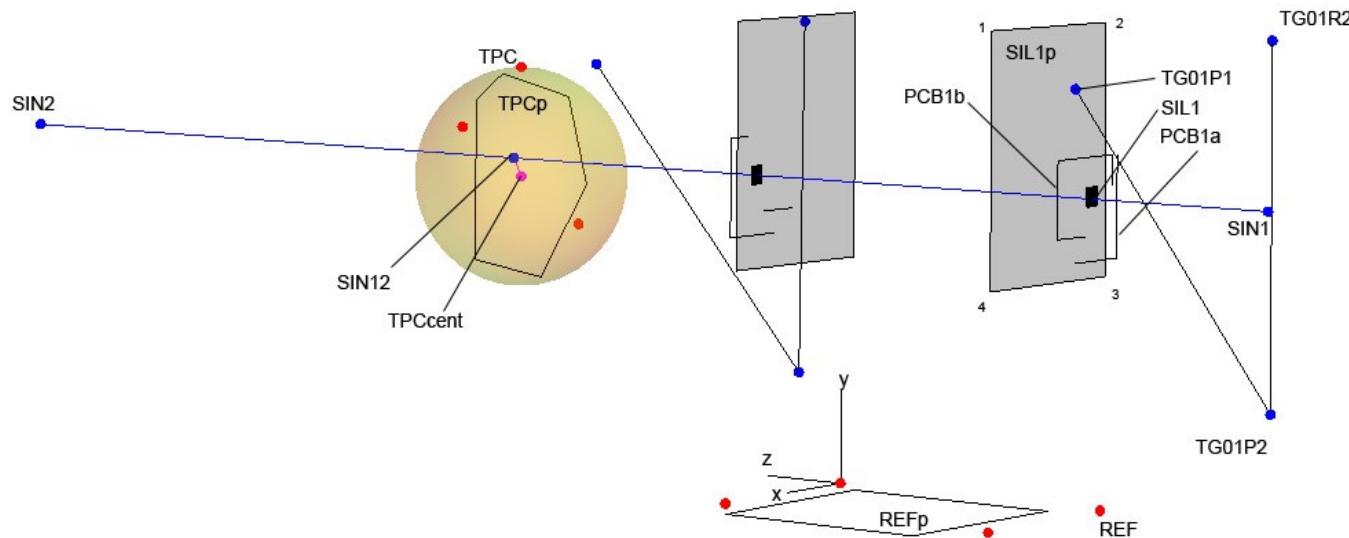
GEM-TPC test bench



- Tracking telescope consisting of 2 GEM detectors and 2 Silicon detector
- Small GEM-TPC on a orientable support
- Setup rearranged to minimize multiple scattering

Geometry and photometry

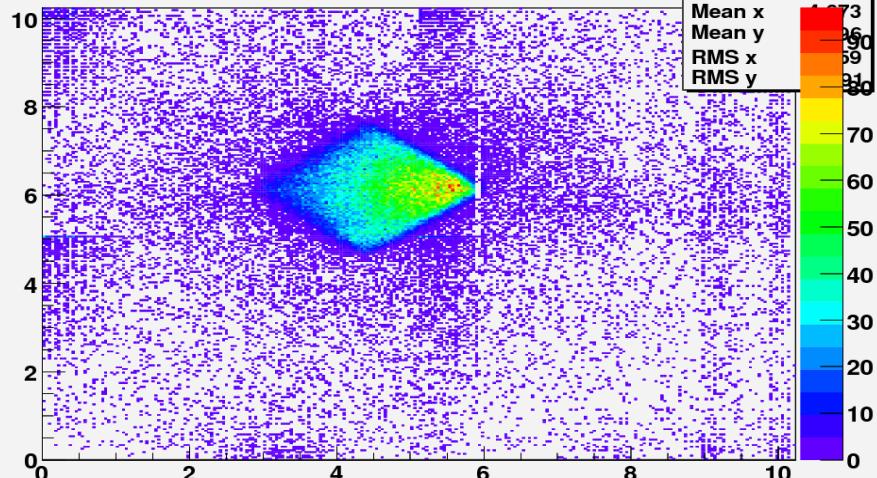
- 3D geometry created using the software Photomodeler and pictures from several angles
- Given a reference length it calculates the relative positions of the different points
- Final alignment done with tracks



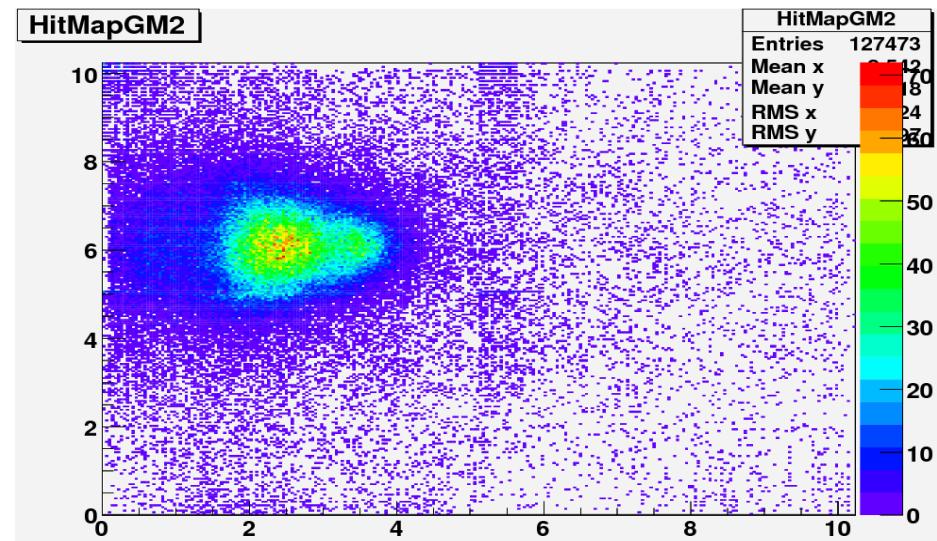
Thanks to Alexander Schmah and Alexander Prehn for doing these measurements

First results of the tracking telescope

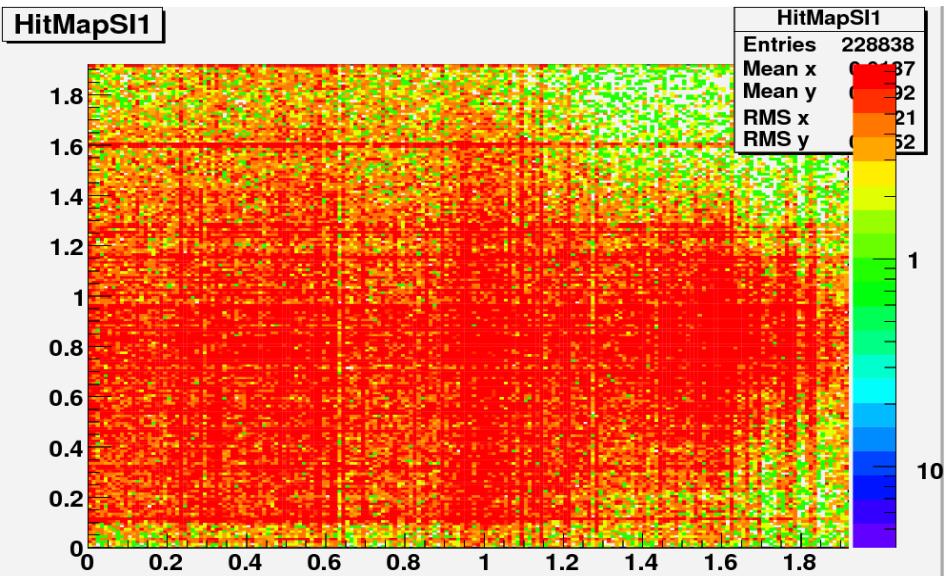
HitMapGM1



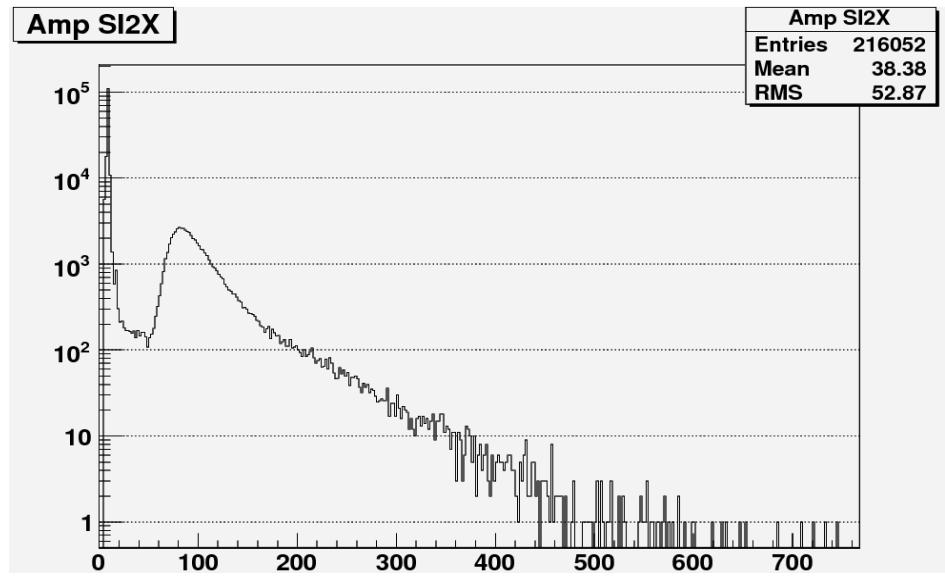
HitMapGM2



HitMapSI1



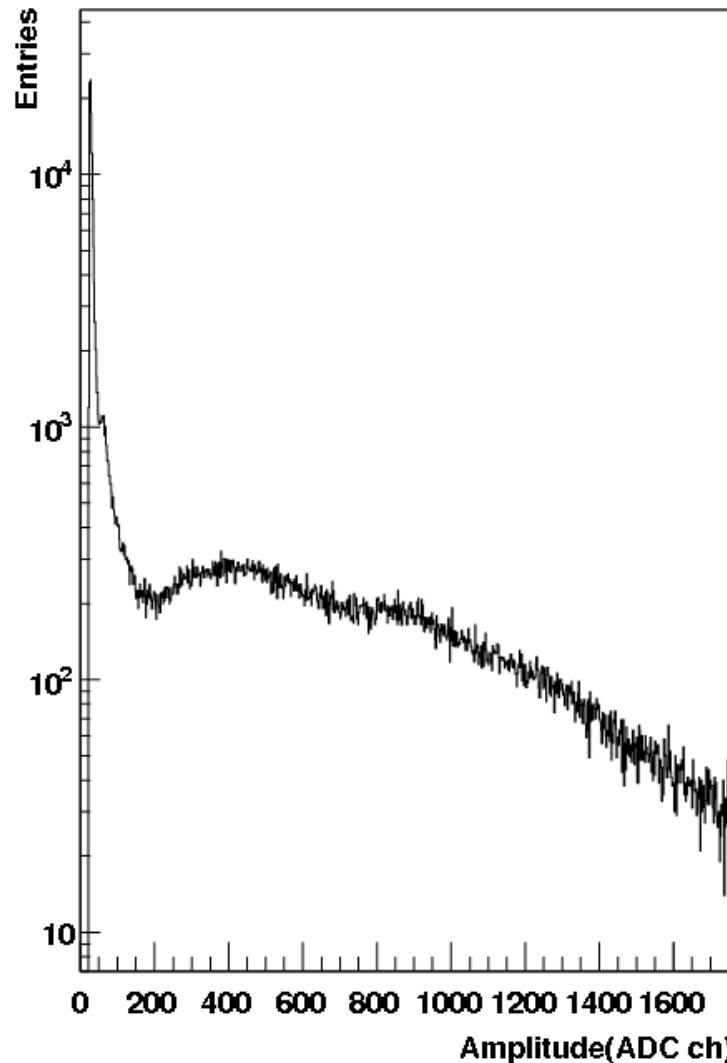
Amp SI2X



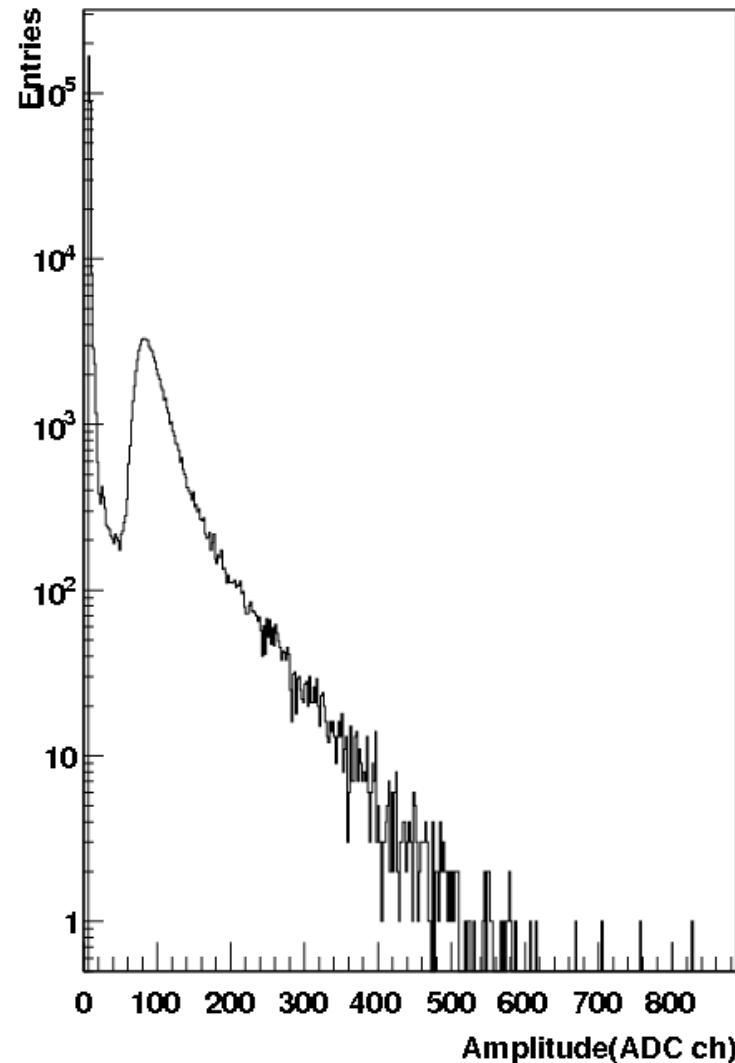
First results of the tracking telescope

- Cluster amplitude of the tracking telescope

GM01X amplitudes

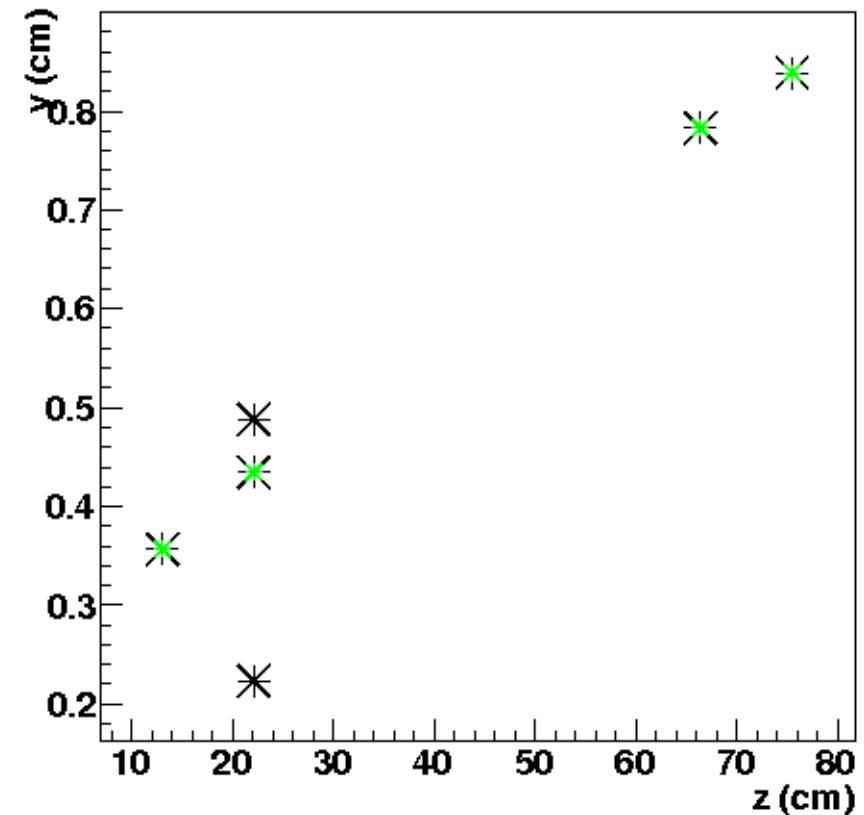
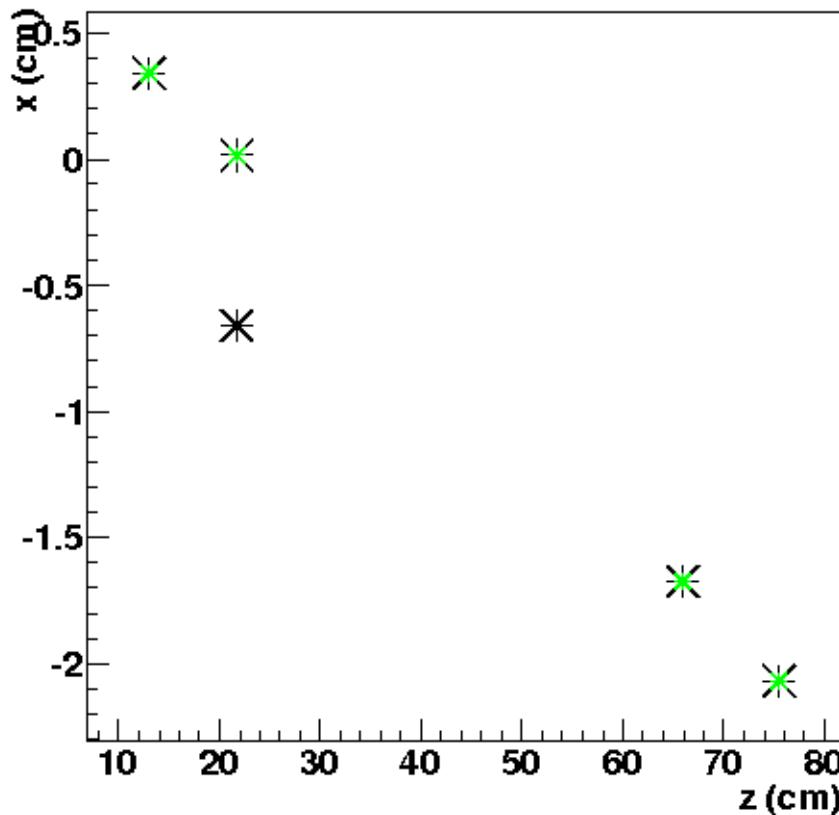


SI01X amplitudes



Track reconstruction

- The Fast Hough Transform is used for pattern recognition. Cf. Felix Boehmer talk in the computing session yesterday
- The black spots are the clusters in the event, the ones colored green are used for one track

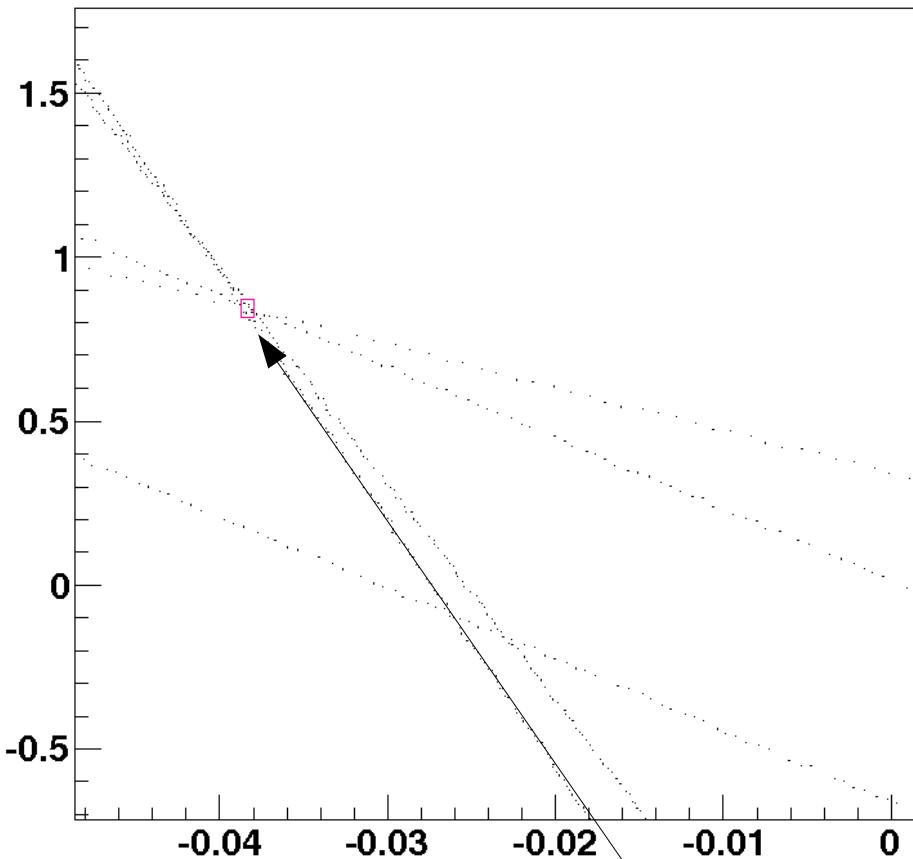


Results from S. Doerheim

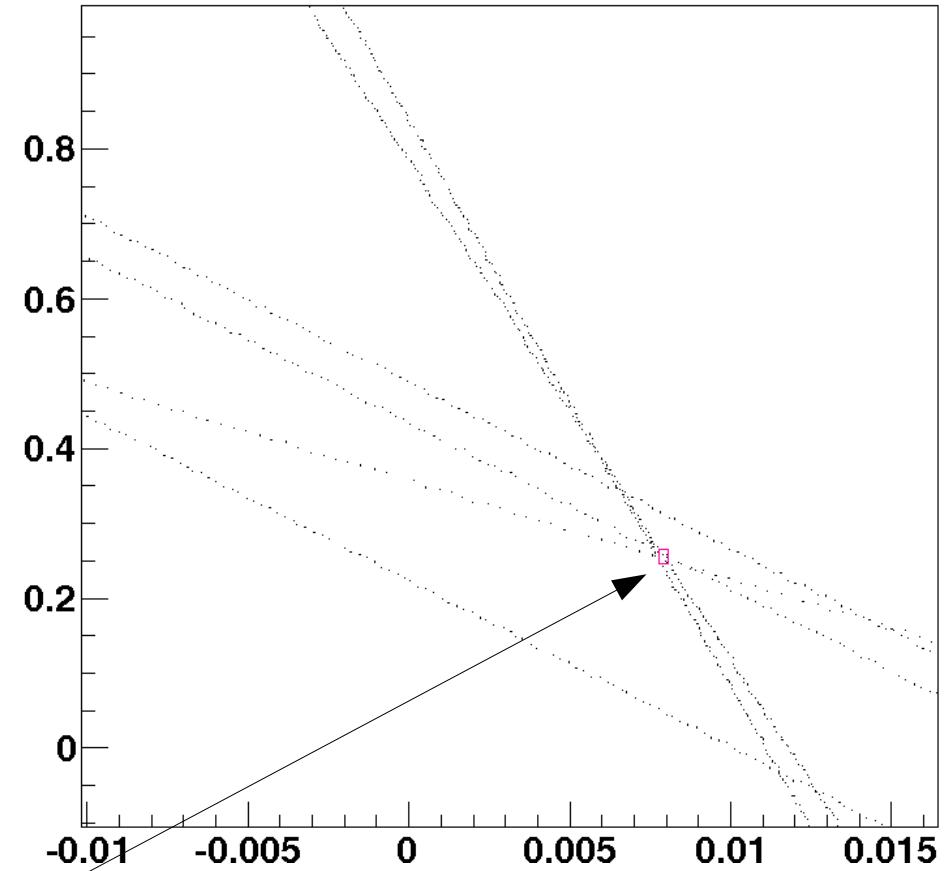
Track reconstruction

- Here you can see the hough space for the event shown on the last slide

houghspaceXZ



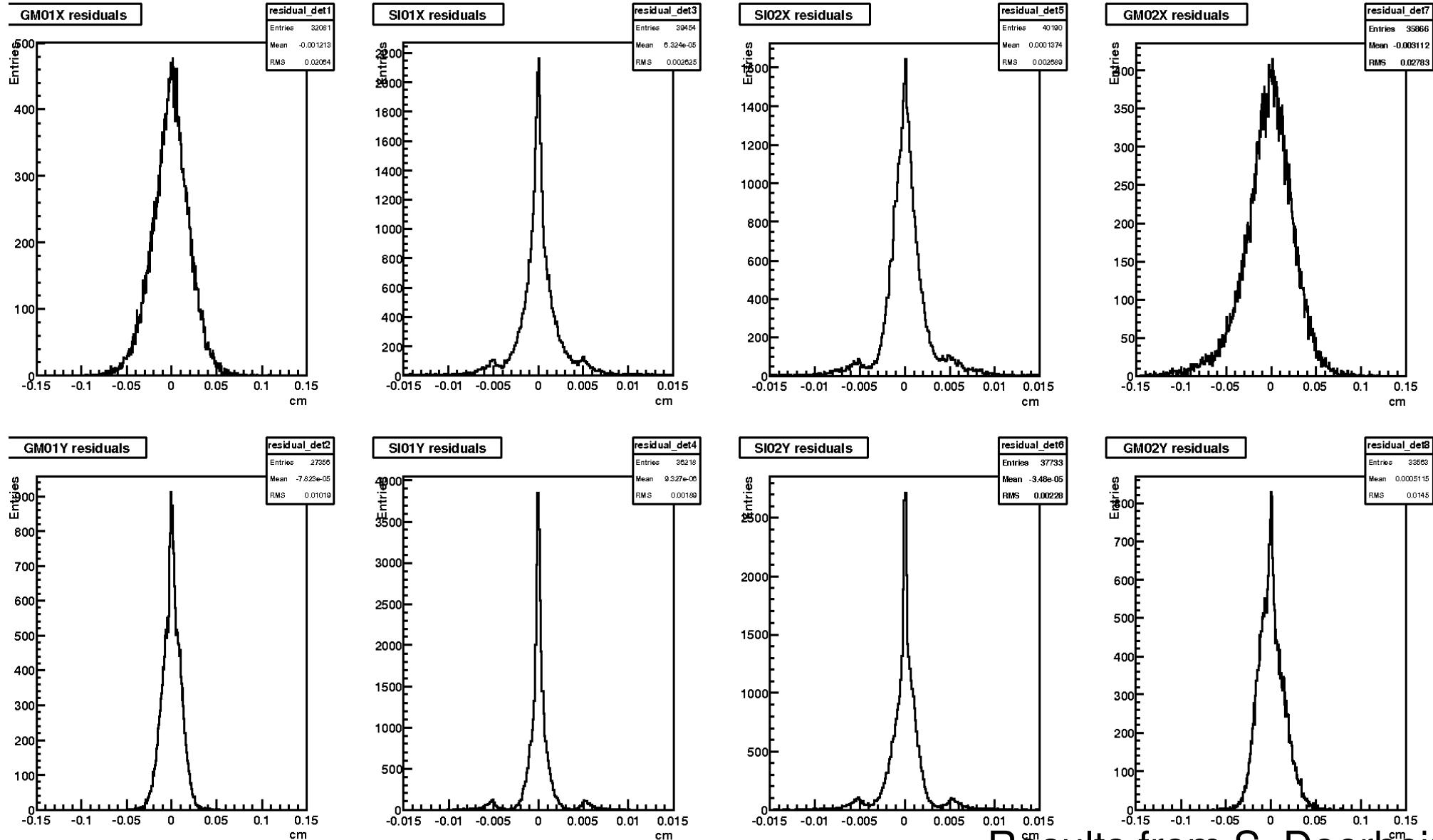
houghspaceYZ



Results from S. Doerheim

Tracking telescope residuals

- Residuals of $\sim 25\mu\text{m}$ for the Silicons and $\sim 200\mu\text{m}$ for the GEMs



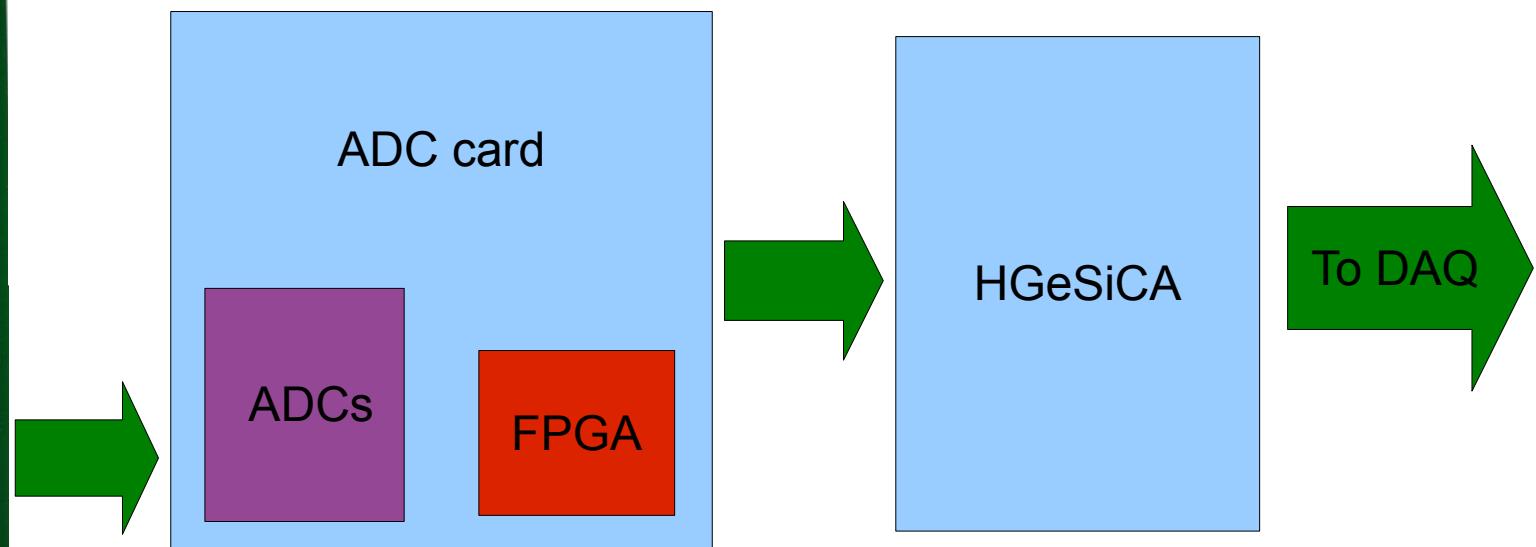
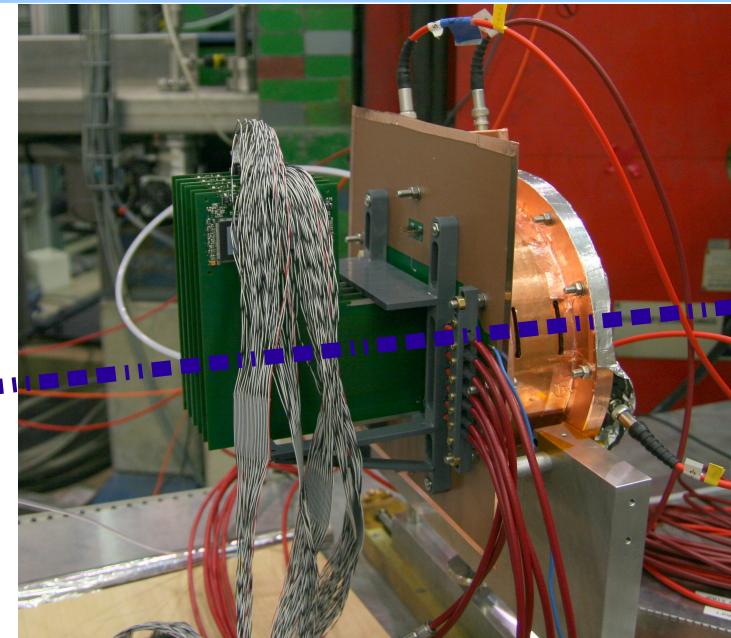
Results from S. Doerheim

Front-end cards :

- 4xT2K chips
- 256 channels
- L-shaped to place chips outside of beam

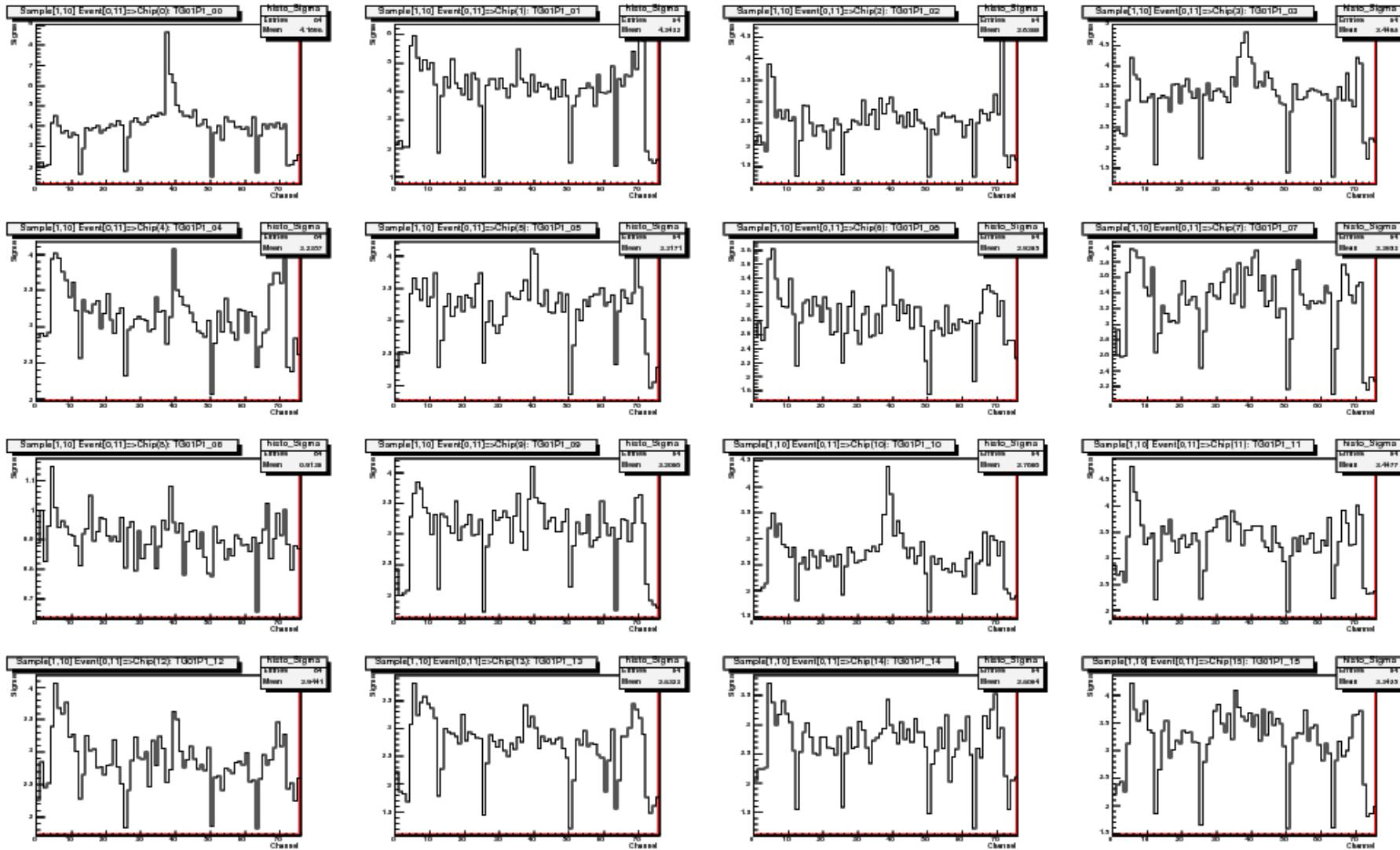
Acquisition setup :

- 6 T2K LCards
- 2 ADCs
- 2 data concentrators (HGeSiCA)



GEM-TPC test chamber data - noise

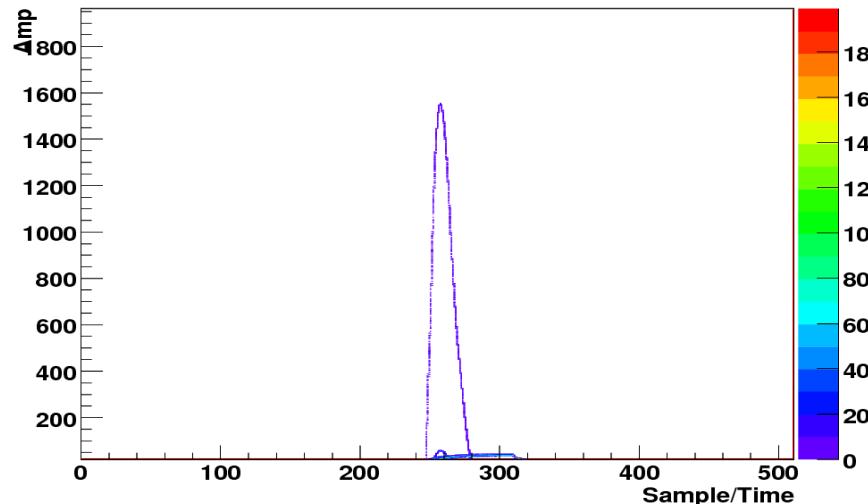
- 16 T2K chips noise measurement using the new latch-all mode firmware



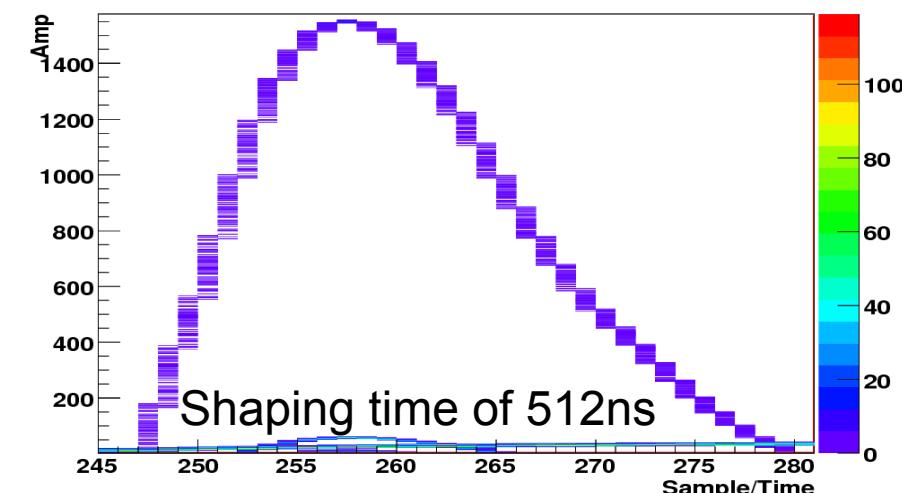
- Good noise performance ($1200e^-$)

- Sparse readout test with an injected pulse

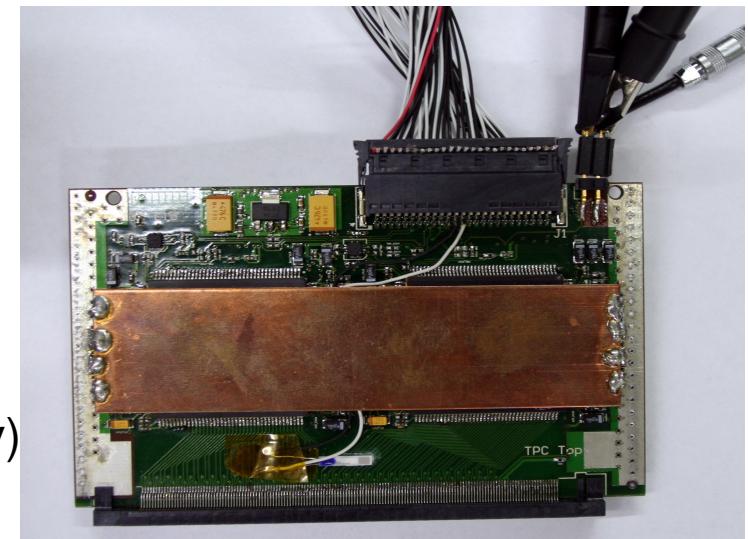
channelId[0,75]:Event[0,145]==>Chip(1): TG01P1_01



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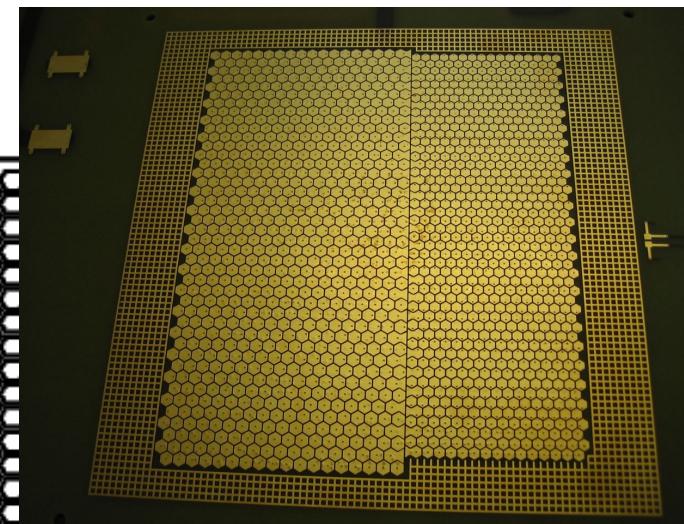
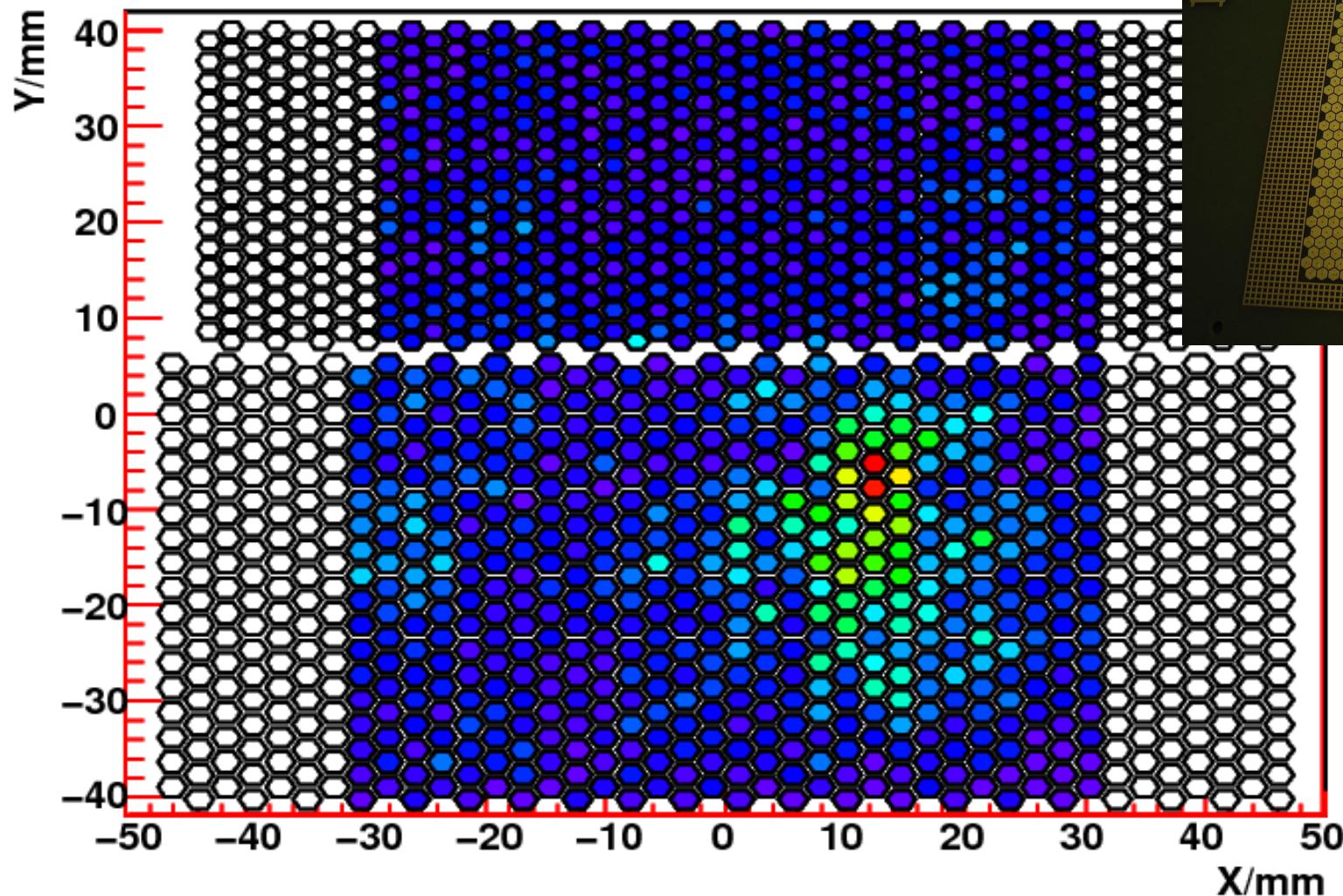


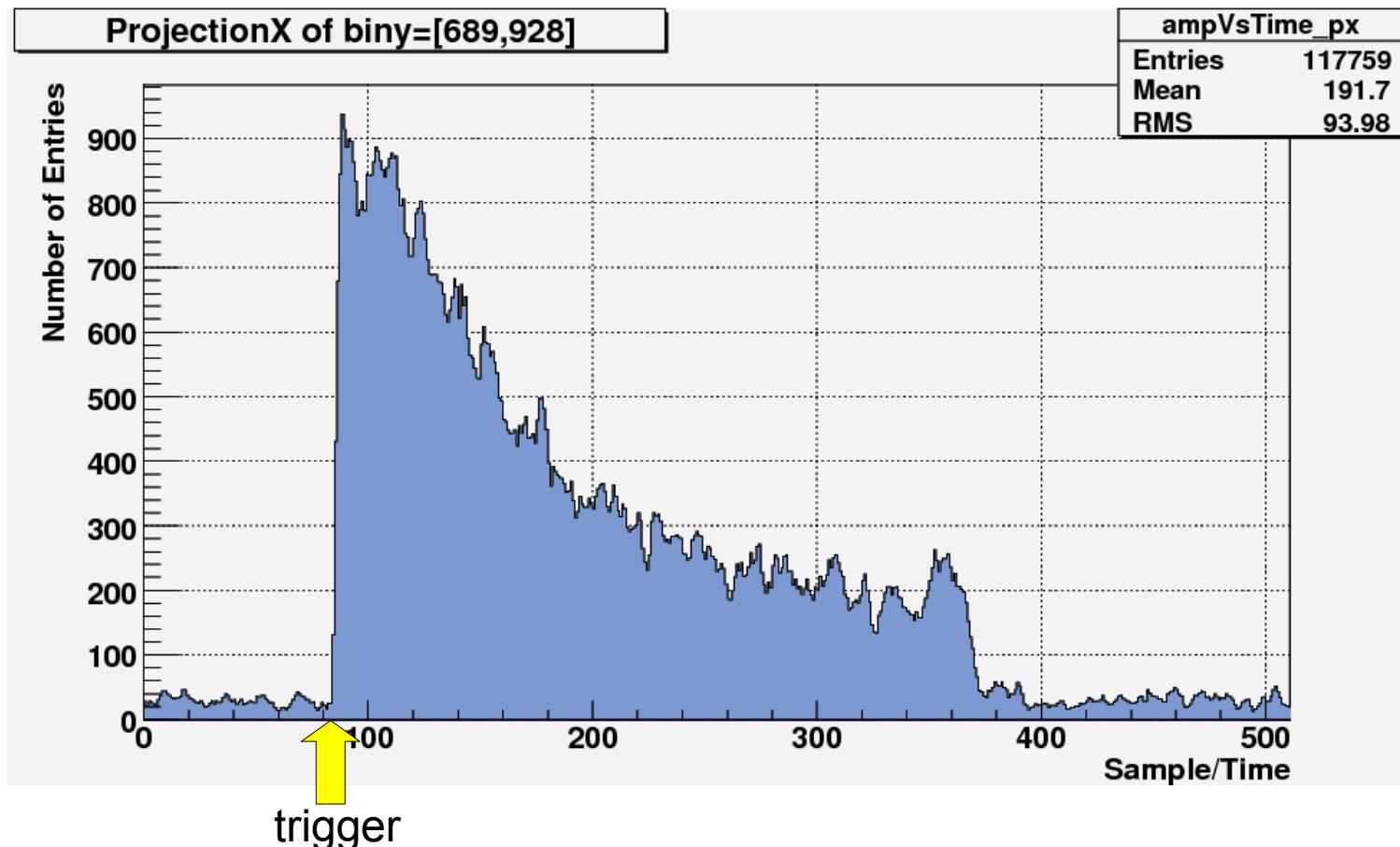
- Full sparse mode working and tested
- Dead time for data readout
- Occupancy max of 1Kw/chip due to ADC memory size
 - Not a problem for the test bench (about 100 value/ev)



- Beam profile using the online decoding program

2D Beam Profile, Event[5, 177]

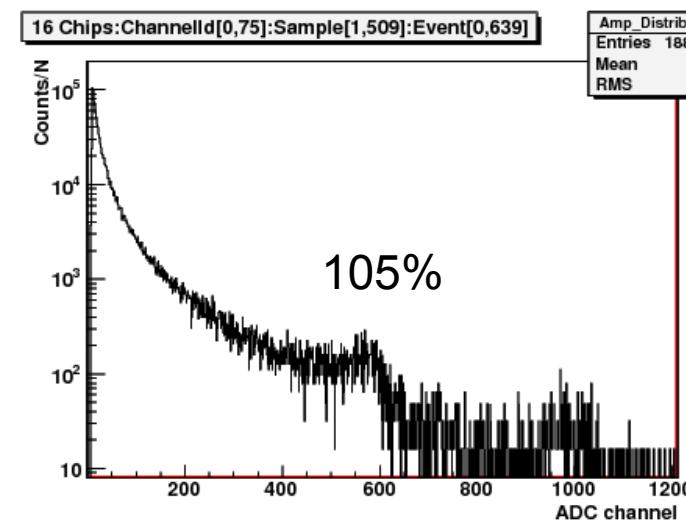
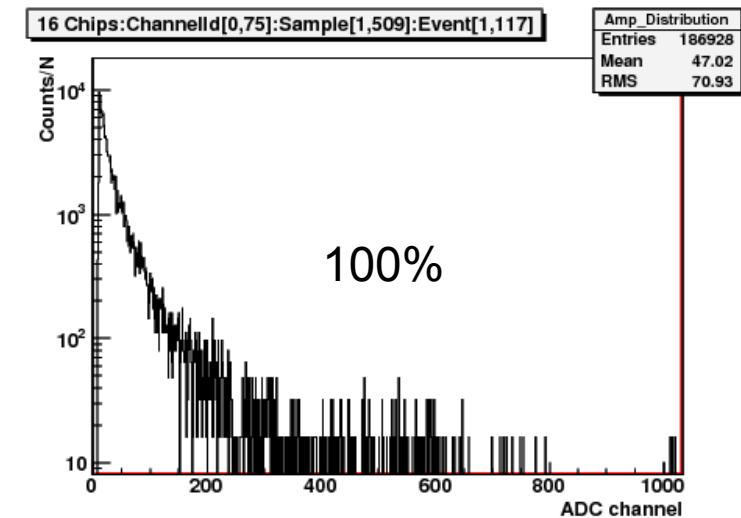
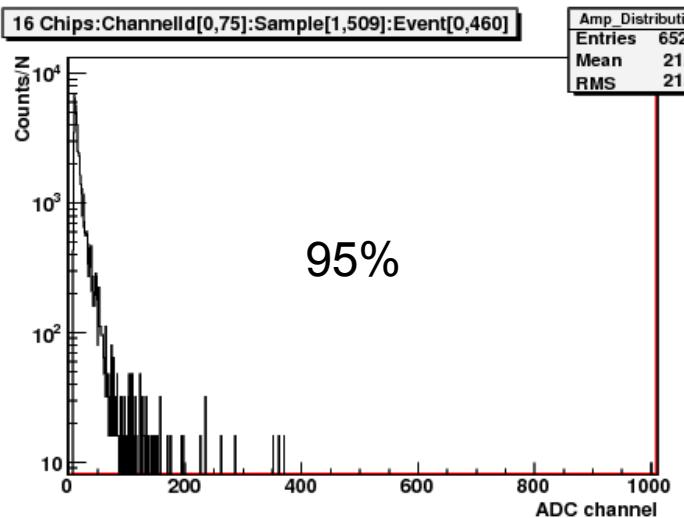




- Trigger correlated signals
- Drift time of 286 samples => $14.3\mu\text{s}$ as expected

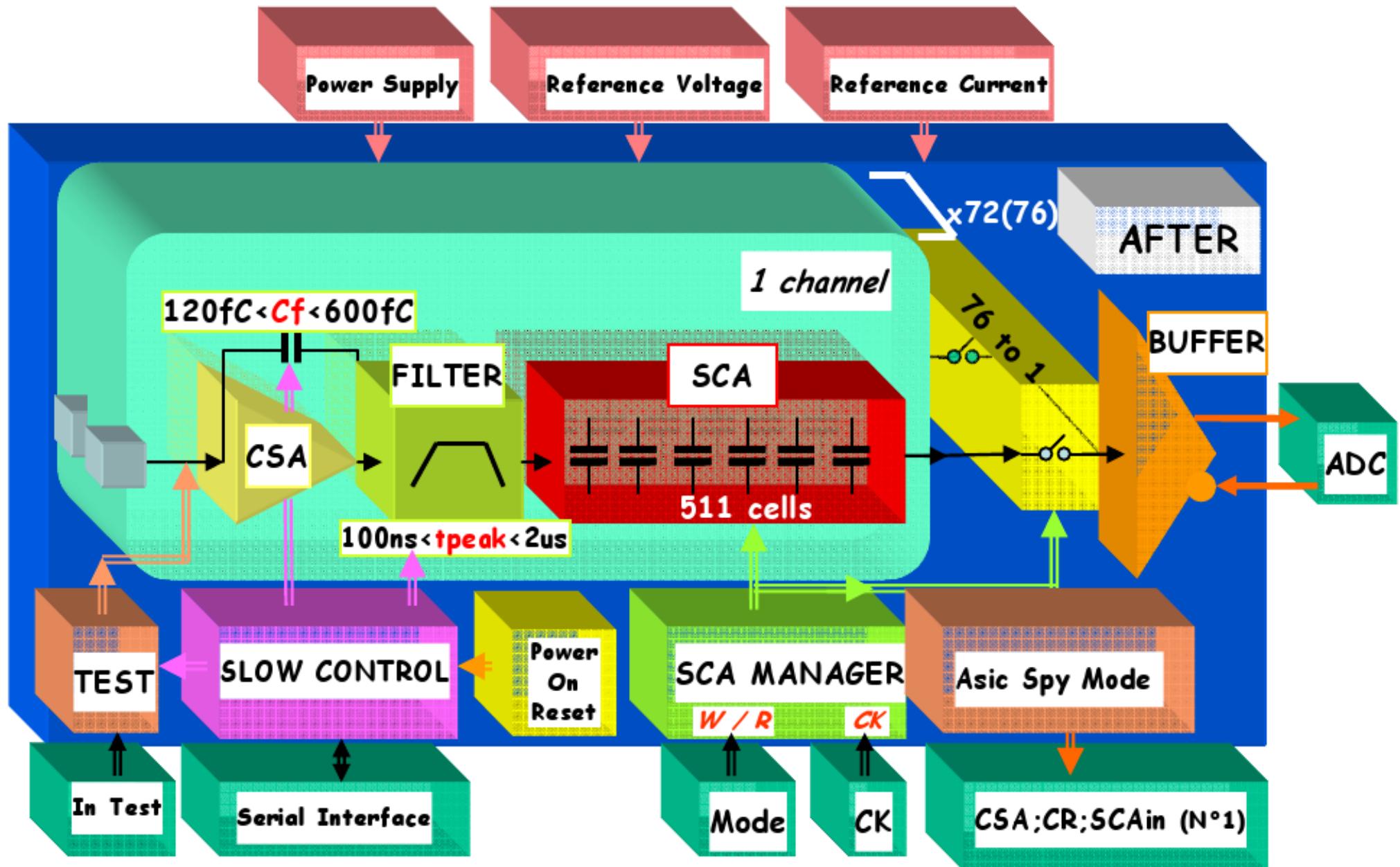
GEM-TPC prototype data

- Gain scan from 95% to 105% of the GEM amplification high-voltage
- Signals amplitude in ADC channel (5.5pC/ADC ch.)



- Fully working tracking telescope
- Geometry file from photometry
- Track reconstruction working
- TPC sparse readout working
- Test data taken during Summer :
 - Gain scan
 - Drift field scan

- TPC data analysis with the pandaroot framework
- Ongoing data taking :
 - Shooting the beam through the thicker cathode
 - Gaz test (Ar/CO₂ 90/10, Ne/CO₂)
 - Different angle between the beam and the pad plane
 - Small/big pads resolution
- Replacement of the cathode (?)
- Measurement of ion backflow



SCA : Switched Capacitor Array